Application/Control No. Applicant(s)/Patent Under Reexamination 10/052,249 MEIER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 3729 Donghai D. Nguyen **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY X 29/879 US-4,573,265 03-1986 Conaway et al. 75/232 В US-5,429,656 07-1995 Hauner et al. С US-US-D Ε US-US-F G US-US-Н US-US-J Κ US-US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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